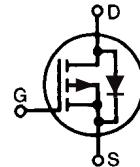


Standard Power MOSFET

P-Channel Enhancement Mode
Avalanche Rated

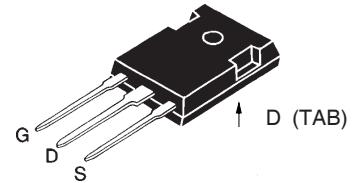
IXTH 24P20 IXTT 24P20

V_{DSS} = -200 V
 I_{D25} = -24 A
 $R_{DS(on)}$ \leq 0.15 Ω

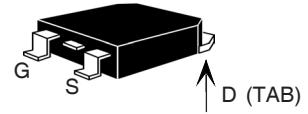


Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	T_J = 25°C to 150°C	-200		V
V_{DGR}	T_J = 25°C to 150°C; $R_{GS} = 1\text{ M}\Omega$	-200		V
V_{GS}	Continuous	± 20		V
V_{GSM}	Transient	± 30		V
I_{D25}	$T_c = 25^\circ\text{C}$	-24		A
I_{DM}	$T_c = 25^\circ\text{C}$, pulse width limited by T_J	-96		A
I_{AR}	$T_c = 25^\circ\text{C}$	-24		A
E_{AR}	$T_c = 25^\circ\text{C}$	30		mJ
P_D	$T_c = 25^\circ\text{C}$	300		W
T_J		-55 ... +150		°C
T_{JM}		150		°C
T_{stg}		-55 ... +150		°C
	Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s	400		°C
	Plastic Body for 10s	250		°C
M_d	Mounting torque (TO-247)	1.13/10	Nm/lb.in.	
Weight	TO-247	6		g
	TO-268	5		g

TO-247 (IXTH)



TO-268 (IXTT)



G = Gate, D = Drain,
S = Source, TAB = Drain

Features

- International standard packages
- Low $R_{DS(on)}$ HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance (<5 nH)
 - easy to drive and to protect

Applications

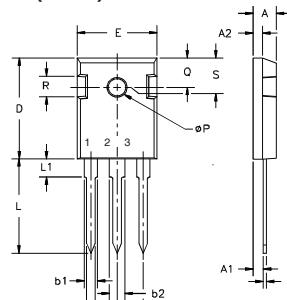
- High side switching
- Push-pull amplifiers
- DC choppers
- Automatic test equipment

Advantages

- Easy to mount with 1 screw (isolated mounting screw hole)
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values		
		min.	typ.	max.
g_{fs}	$V_{DS} = -10 \text{ V}; I_D = I_{D25}$, pulse test	10	15	S
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$	4200	pF	
		830	pF	
		350	pF	
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	$V_{GS} = -10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 0.5 I_{D25}$ $R_G = 4.7 \Omega$ (External)	36	ns	
		29	ns	
		68	ns	
		28	ns	
$Q_{g(on)}$ Q_{gs} Q_{gd}	$V_{GS} = -10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 0.5 I_{D25}$	150	nC	
		40	nC	
		70	nC	
R_{thJC}			0.42	K/W
R_{thCS}	(TO-247)	0.25		K/W

TO-247 (IXTH) Outline



Terminals: 1 - Gate 2 - Drain
3 - Source Tab - Drain

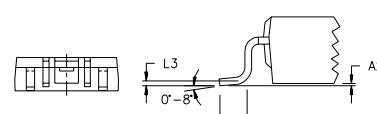
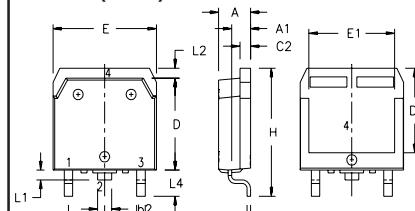
Dim.	Millimeter Min.	Millimeter Max.	Inches Min.	Inches Max.
A	4.7	5.3	.185	.209
A ₁	2.2	2.54	.087	.102
A ₂	2.2	2.6	.059	.098
b	1.0	1.4	.040	.055
b ₁	1.65	2.13	.065	.084
b ₂	2.87	3.12	.113	.123
C	.4	.8	.016	.031
D	20.80	21.46	.819	.845
E	15.75	16.26	.610	.640
e	5.20	5.72	0.205	0.225
L	19.81	20.32	.780	.800
L ₁		4.50		.177
ØP	3.55	3.65	.140	.144
Q	5.89	6.40	0.232	0.252
R	4.32	5.49	.170	.216
S	6.15	BSC	242	BSC

Source-Drain Diode

Characteristic Values
($T_J = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Test Conditions	min.	typ.	max.
I_s	$V_{GS} = 0$		-24	A
I_{SM}	Repetitive; pulse width limited by T_{JM}		-96	A
V_{SD}	$I_F = I_s, V_{GS} = 0 \text{ V},$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$		-3	V
t_{rr}	$I_F = I_s, di/dt = 100 \text{ A}/\mu\text{s}, V_R = -50 \text{ V}$	250		ns

TO-268 (IXTT) Outline



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A ₁	.106	.114	2.70	2.90
A ₂	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b ₂	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C ₂	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D ₁	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E ₁	.524	.535	13.30	13.60
e	.215	BSC	5.45	BSC
H	.736	.752	18.70	19.10
L	.094	.106	2.40	2.70
L ₁	.047	.055	1.20	1.40
L ₂	.039	.045	1.00	1.15
L ₃	.010	BSC	0.25	BSC
L ₄	.150	.161	3.80	4.10

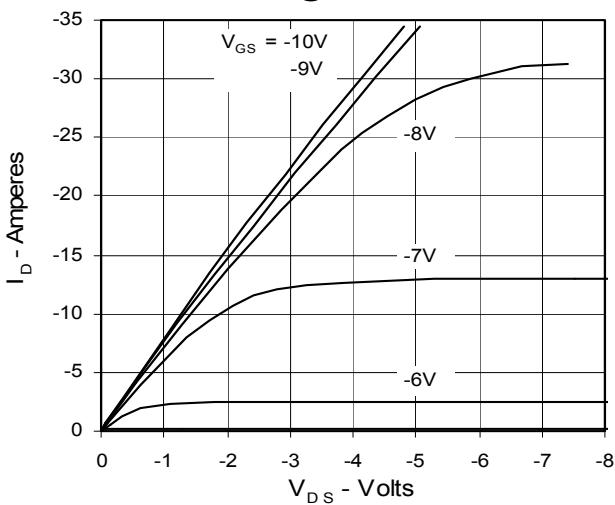
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

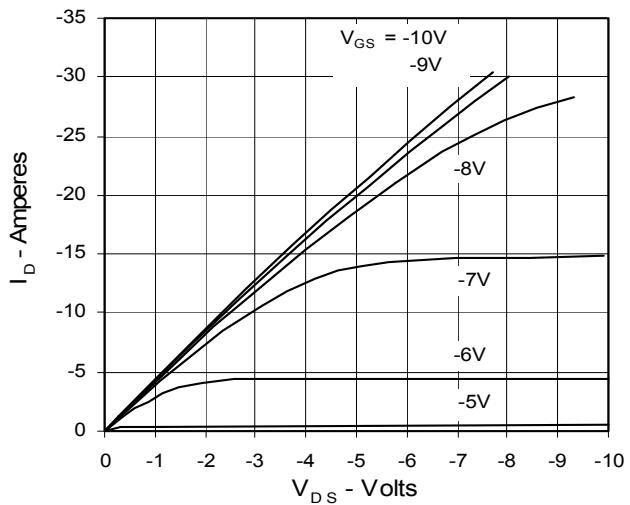
4,835,592	4,931,844	5,049,961	5,237,481	6,162,665	6,404,065 B1
4,850,072	5,017,508	5,063,307	5,381,025	6,259,123 B1	6,534,343
4,881,106	5,034,796	5,187,117	5,486,715	6,306,728 B1	6,583,505

6,683,344	6,727,585
6,710,405 B2	6,759,692
6,710,463	6,771,478 B2

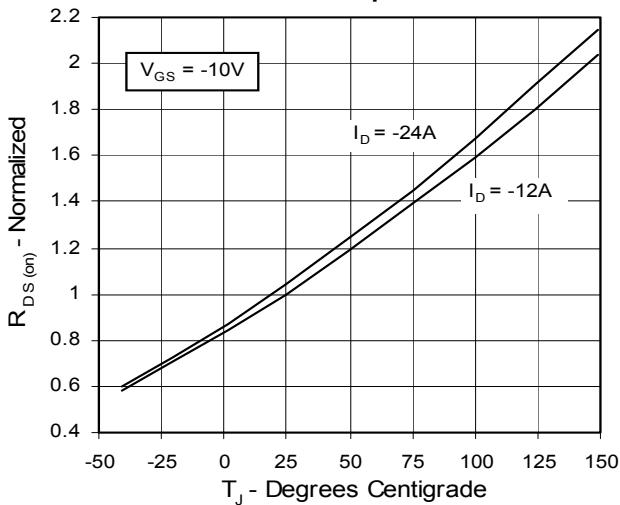
**Fig. 1. Output Characteristics
@ 25°C**



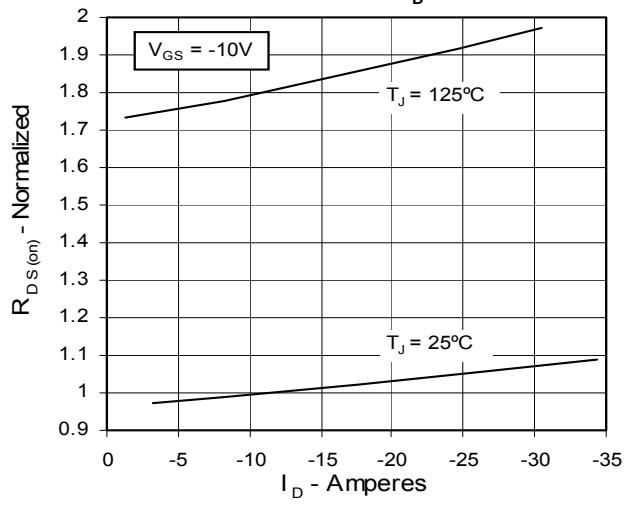
**Fig. 2. Output Characteristics
@ 125°C**



**Fig. 3. $R_{DS(on)}$ Normalized to I_{D25} Value vs.
Junction Temperature**



**Fig. 4. $R_{DS(on)}$ Normalized to I_{D25}
Value vs. I_D**



**Fig. 5. Drain Current vs. Case
Temperature**

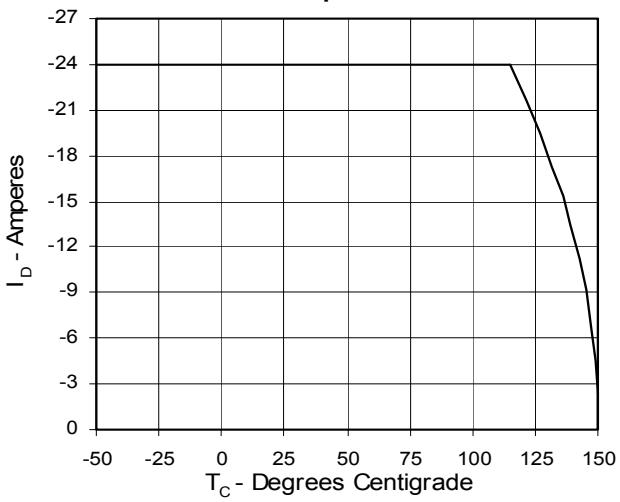


Fig. 6. Input Admittance

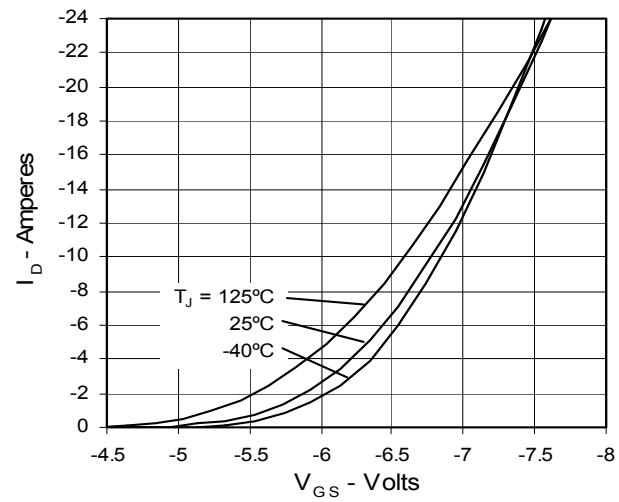


Fig. 7. Transconductance

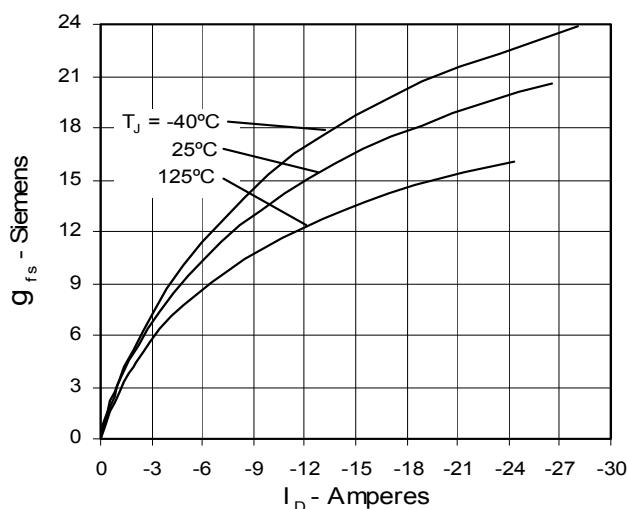


Fig. 8. Source Current vs. Source-To-Drain Voltage

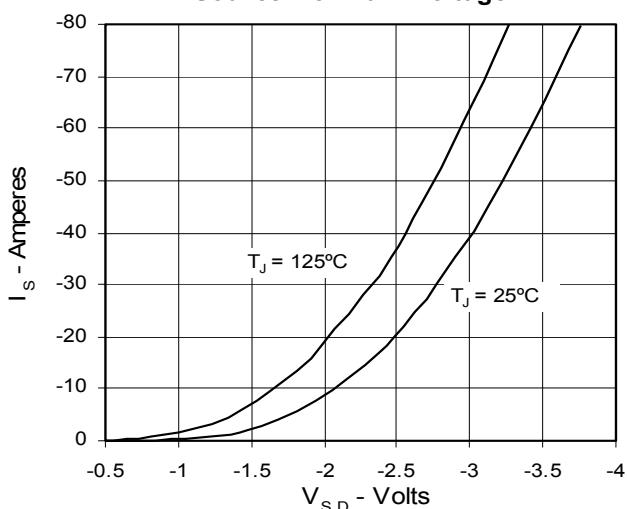


Fig. 9. Gate Charge

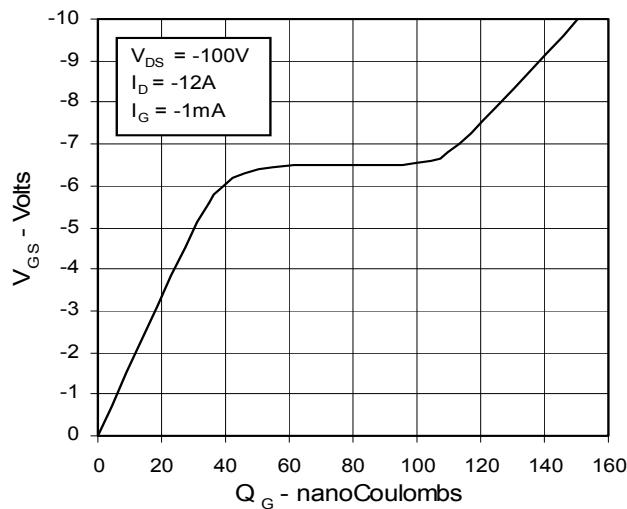


Fig. 11. Capacitance

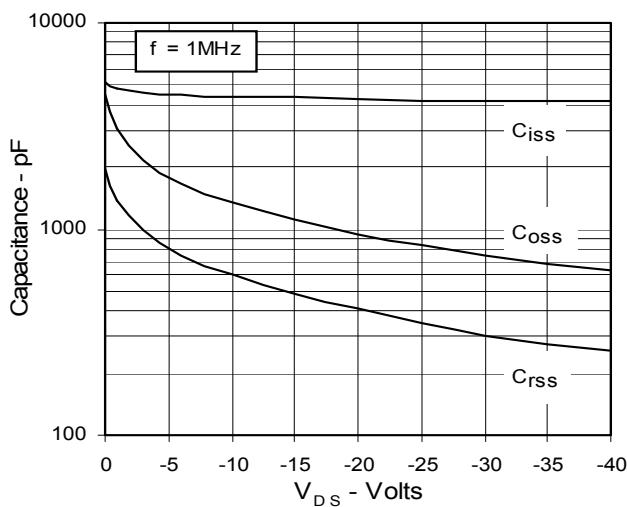


Fig. 10. Temperature dependence of Breakdown and Threshold Voltage

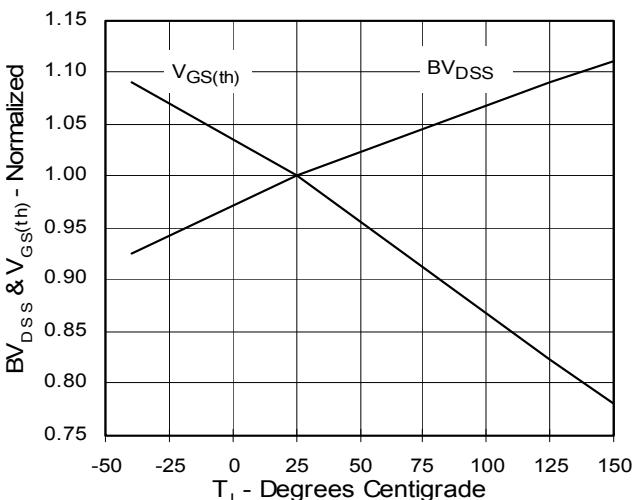


Fig. 12. Forward-Bias Safe Operating Area

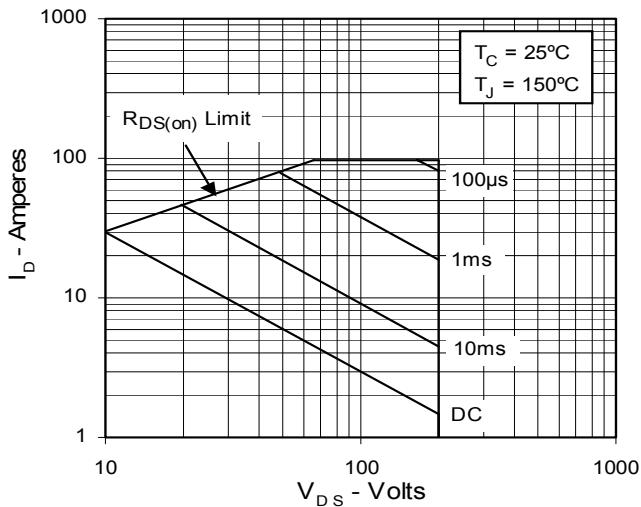
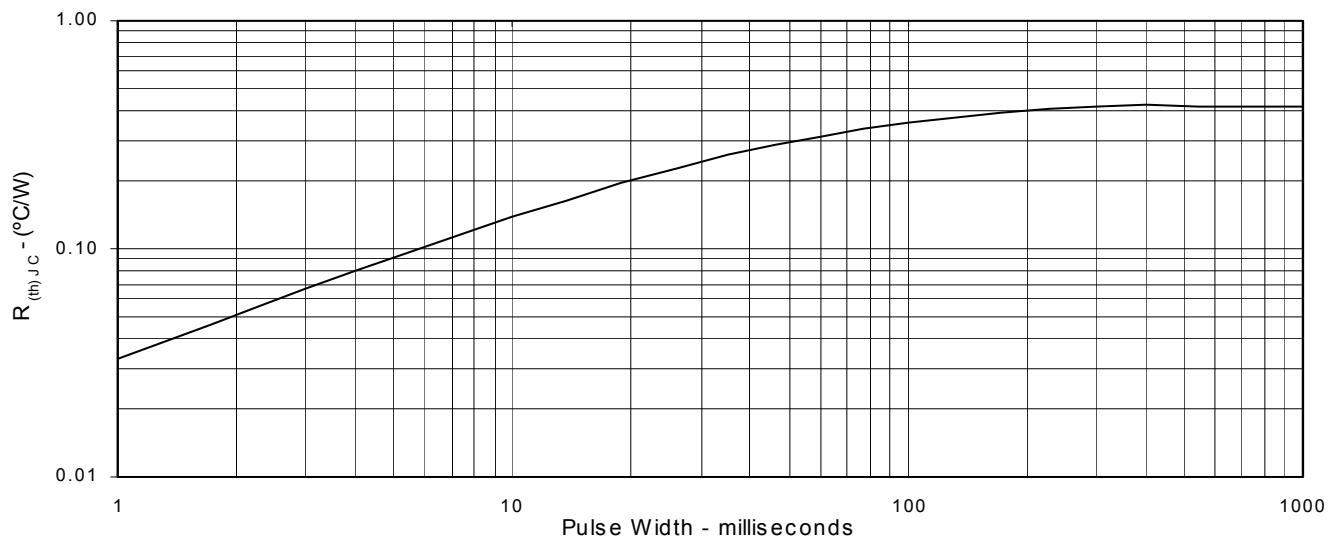


Fig. 13. Maximum Transient Thermal Resistance

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[DMN1006UCA6-7](#) [DMN16M9UCA6-7](#)